

Data reporting template (metadata) for LA-ICP-MS

(adapted from <http://www.plasmage.org/recommendations>)

Laboratory & Sample Preparation	
Laboratory name	School of Environment, Earth and Ecosystem Sciences, Open University, UK
Sample type/mineral	Mafic granulites/Amp, Pl, Cpx, Opx
Sample preparation	Polished thin sections
Laser ablation system	
Make, Model & type	Photon Machines Analyte G2 193 nm excimer laser
Ablation cell & volume	HelEx II 2-volume cell
Laser wavelength (nm)	193 nm
Pulse width (ns)	4 ns
Fluence (J/cm ²)	3.63 J/cm ²
Repetition rate (Hz)	10 Hz
Ablation duration (s)	30 s
Spot diameter (µm)	50 µm, reduced to 40 µm for certain interstitial Pl films
Sampling mode / pattern	static spots
Carrier gas	100% He in the cell, Ar make-up gas combined in a mixing bulb down stream.
Cell carrier gas flow (l/min)	0.9 l/min He
ICP-MS Instrument	
Make, Model & type	Agilent 8800 ICP-QQQ-MS
Sample introduction	Ablation aerosol in He & Ar gas mix
RF power (W)	1250 W
Ar carrier gas flow (l/min)	~0.77 l/min
Detection system	Dual-mode discrete dynode electron multiplier
Masses measured; Integration time per peak/dwell times (ms)	⁷ Li 0.005; ⁹ Be 0.005; ²³ Na 0.002; ²⁴ Mg 0.005; ²⁷ Al 0.002; ²⁹ Si 0.002; ³¹ P 0.01; ³⁹ K 0.005; ⁴³ Ca 0.005; ⁴⁵ Sc 0.005; ⁴⁹ Ti 0.005; ⁵¹ V 0.005; ⁵³ Cr 0.005; ⁵⁵ Mn 0.005; ⁵⁶ Fe 0.005; ⁵⁹ Co 0.005; ⁶⁰ Ni 0.005; ⁶⁵ Cu 0.005; ⁶⁶ Zn 0.005; ⁷¹ Ga 0.005; ⁷⁴ Ge 0.005; ⁸⁵ Rb 0.005; ⁸⁸ Sr 0.005; ⁸⁹ Y 0.005; ⁹⁰ Zr 0.005; ⁹³ Nb 0.01; ⁹⁵ Mo 0.01; ¹¹¹ Cd 0.01; ¹¹⁵ In 0.01; ¹¹⁸ Sn 0.01; ¹²¹ Sb 0.02; ¹³³ Cs 0.02; ¹³⁷ Ba 0.01; ¹³⁹ La 0.01; ¹⁴⁰ Ce 0.01; ¹⁴¹ Pr 0.01; ¹⁴⁶ Nd 0.01; ¹⁴⁷ Sm 0.01; ¹⁵³ Eu 0.01; ¹⁵⁷ Gd 0.01; ¹⁵⁹ Tb 0.01; ¹⁶³ Dy 0.01; ¹⁶⁵ Ho 0.01; ¹⁶⁶ Er 0.01; ¹⁶⁹ Tm 0.01; ¹⁷² Yb 0.01; ¹⁷⁵ Lu 0.01; ¹⁷⁷ Hf 0.01; ¹⁸¹ Ta 0.01; ¹⁸² W 0.02; ²⁰⁵ Tl 0.02; ²⁰⁸ Pb 0.02; ²⁰⁹ Bi 0.02; ²³² Th 0.01; ²³⁸ U 0.01
Total integration time (s)	0.6504
Gas blank	30 seconds
Washout	40 seconds
Data Processing	
Calibration strategy	SRM-NIST 612 (primary for trace elements), BCR-2G (secondary for traces, primary for majors) every ~20 analyses
Reference Material info	SRM-NIST 612 (Jenner and O'Neill, 2012) BCR-2G (Jenner and O'Neill, 2012 & in house long-term

	averages)
Data processing package used	Iolite v3.71; DRS: X_Trace_Elements_IS; internal standard ²⁹ Si
Uncertainty level & Quality control / Validation	BCR-2G within 3-10% of the preferred value depending on element concentration and homogeneity of secondary standard. Major element concentrations obtained by LA-ICP-MS were compared to those measured by EMPA for consistency checks and data defines on a 1:1 line